

FDD9507L-F085

P-Channel POWERTRENCH[®] MOSFET

–40 V, –100 A, 4.4 mΩ

Features

- Typical $R_{DS(on)} = 3.3\text{ m}\Omega$ at $V_{GS} = -10\text{ V}$, $I_D = -80\text{ A}$
- Typical $G_{g(tot)} = 110\text{ nC}$ at $V_{GS} = -10\text{ V}$, $I_D = -80\text{ A}$
- UIS Capability
- Qualified to AEC Q101
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Automotive Engine Control
- PowerTrain Management
- Solenoid and Motor Drivers
- Electrical Power Steering
- Integrated Starter/Alternator
- Distributed Power Architectures and VRM
- Primary Switch for 12 V Systems

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-to-Source Voltage	–40	V
V_{GS}	Gate-to-Source Voltage	±16	V
I_D	Drain Current – Continuous, ($V_{GS} = -10\text{ V}$) $T_C = 25^\circ\text{C}$ (Note 1)	–100	A
	Pulsed Drain Current, $T_C = 25^\circ\text{C}$	(See Figure 4)	A
E_{AS}	Single Pulse Avalanche Energy (Note 2)	259	mJ
P_D	Power Dissipation	227	W
	Derate Above 25°C	1.52	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature	–55 to +175	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

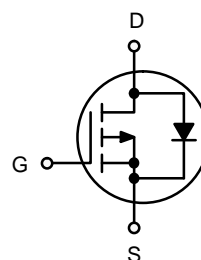
1. Current is limited by bondwire configuration.
2. Starting $T_J = 25^\circ\text{C}$, $L = 0.1\text{ mH}$, $I_{AS} = -72\text{ A}$, $V_{DD} = -40\text{ V}$ during inductor charging and $V_{DD} = 0\text{ V}$ during time in avalanche.



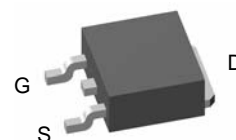
ON Semiconductor[®]

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V_{DSS}	$R_{DS(on)}\text{ MAX}$	$I_D\text{ MAX}$
–40 V	4.4 mΩ @ –10 V	–100 A

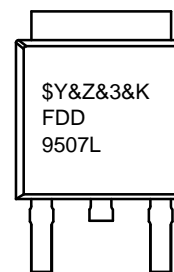


P-CHANNEL MOSFET



DPAK3 (TO-252)
CASE 369AS

MARKING DIAGRAM



\$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
FDD9507L	= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.66	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 3)	52	

3. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

BV_{DSS}	Drain-to-Source Breakdown Voltage	$I_D = -250\ \mu\text{A}$, $V_{GS} = 0\ \text{V}$	-40	-	-	V
I_{DSS}	Drain-to-Source Leakage Current	$V_{DS} = -40\ \text{V}$, $V_{GS} = 0\ \text{V}$ $T_J = 25^\circ\text{C}$ $T_J = 175^\circ\text{C}$ (Note 4)	-	-	1	μA mA
I_{GSS}	Gate-to-Source Leakage Current	$V_{GS} = \pm 16\ \text{V}$	-	-	± 100	nA

ON CHARACTERISTICS

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\ \mu\text{A}$	-1	-2	-3	V
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -4.5\ \text{V}$, $I_D = -80\ \text{A}$, $T_J = 25^\circ\text{C}$	-	4.9	7.2	m Ω
		$V_{GS} = -10\ \text{V}$, $I_D = -80\ \text{A}$ $T_J = 25^\circ\text{C}$ $T_J = 175^\circ\text{C}$ (Note 4)	-	3.3 5.3	4.4 7.1	

DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	$V_{DS} = -20\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	-	6250	-	pF
C_{oss}	Output Capacitance		-	2640	-	pF
C_{rss}	Reverse Transfer Capacitance		-	61	-	pF
R_g	Gate Resistance	$f = 1\ \text{MHz}$	-	19.3	-	Ω
$Q_{g(tot)}$	Total Gate Charge	$V_{GS} = 0\ \text{V}$ to $-10\ \text{V}$, $V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$	-	100	130	nC
$Q_{g(-4.5)}$	Total Gate Charge	$V_{GS} = 0\ \text{V}$ to $-4.5\ \text{V}$, $V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$	-	46	-	nC
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0\ \text{V}$ to $-2\ \text{V}$, $V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$	-	13	-	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$	-	22	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	$V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$	-	13	-	nC

SWITCHING CHARACTERISTICS

t_{on}	Turn-On Time	$V_{DD} = -20\ \text{V}$, $I_D = -80\ \text{A}$, $V_{GS} = -10\ \text{V}$, $R_{GEN} = 6\ \Omega$	-	-	21	ns
$t_{d(on)}$	Turn-On Delay		-	10	-	ns
t_r	Rise Time		-	6	-	ns
$t_{d(off)}$	Turn-Off Delay		-	400	-	ns
t_f	Fall Time		-	132	-	ns
t_{off}	Turn-Off Time		-	-	710	ns

DRAIN-SOURCE DIODE CHARACTERISTICS

V_{SD}	Source to Drain Diode Forward Voltage	$I_{SD} = -80\ \text{A}$, $V_{GS} = 0\ \text{V}$	-	-0.9	-1.3	V
		$I_{SD} = -40\ \text{A}$, $V_{GS} = 0\ \text{V}$	-	-0.85	-1.2	
t_{rr}	Reverse Recovery Time	$I_F = -80\ \text{A}$, $dI_{SD}/dt = 100\ \text{A}/\mu\text{s}$	-	87	113	ns
Q_{rr}	Reverse Recovery Charge		-	115	150	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. The maximum value is specified by design at $T_J = 175^\circ\text{C}$. Product is not tested to this condition in production.

TYPICAL CHARACTERISTICS

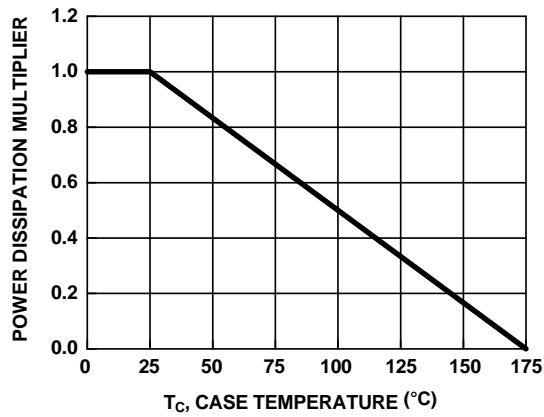


Figure 1. Normalized Power Dissipation vs. Case Temperature

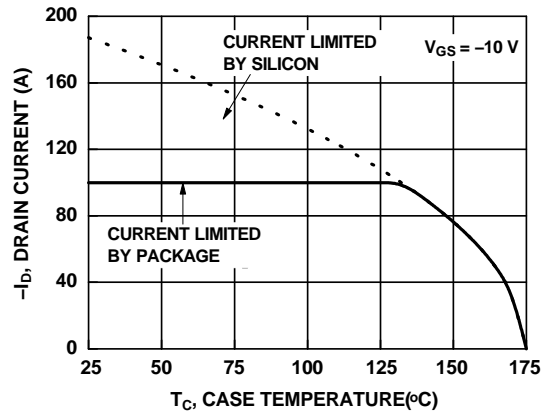


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

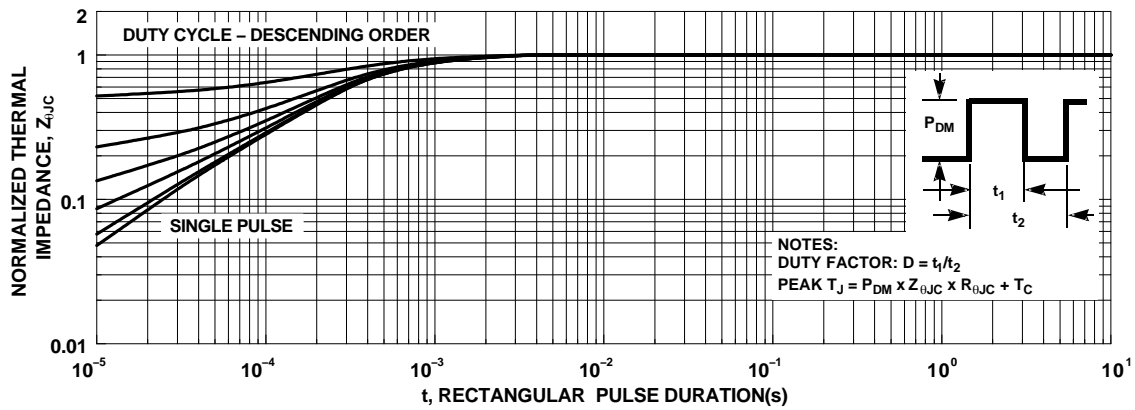


Figure 3. Normalized Maximum Transient Thermal Impedance

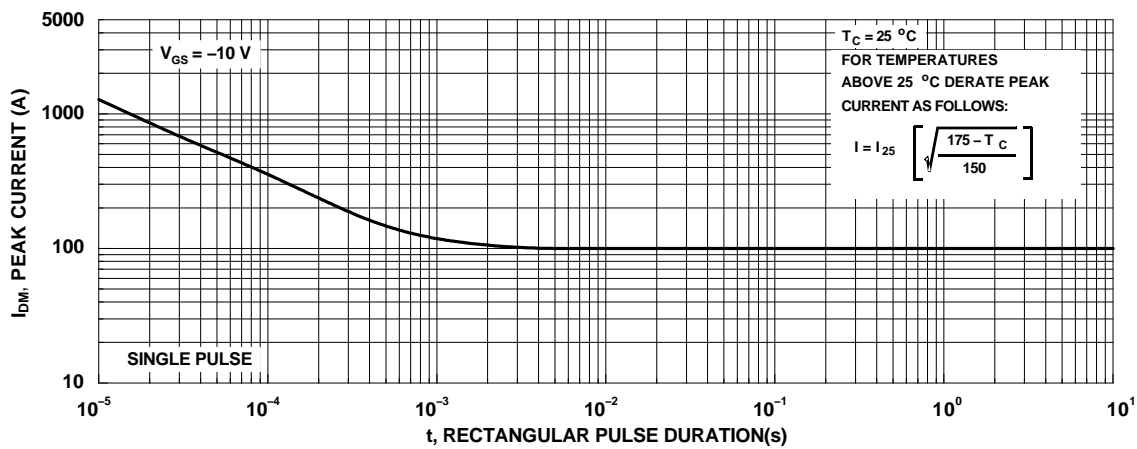


Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS

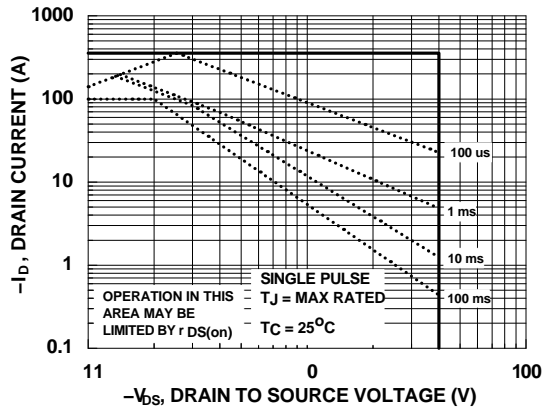


Figure 5. Forward Bias Safe Operating Area

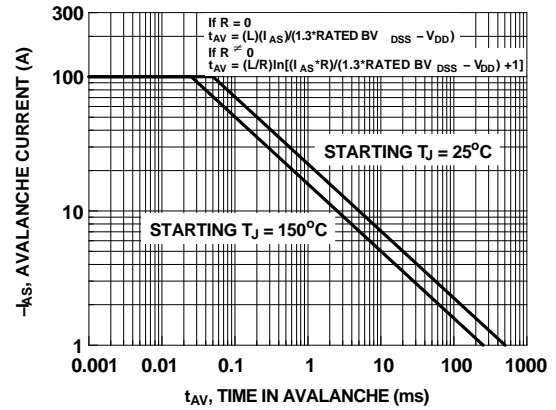


Figure 6. Unclamped Inductive Switching Capability

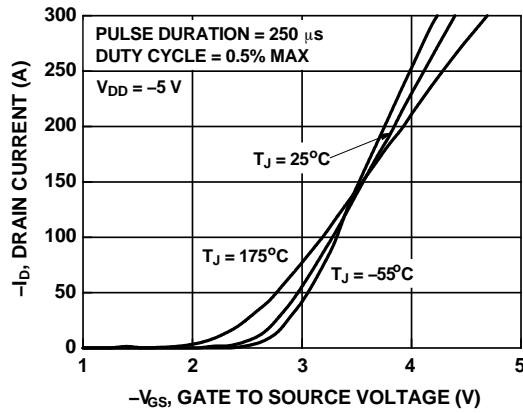


Figure 7. Transfer Characteristics

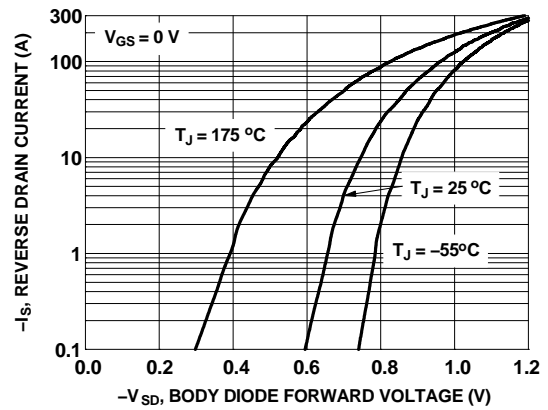


Figure 8. Forward Diode Characteristics

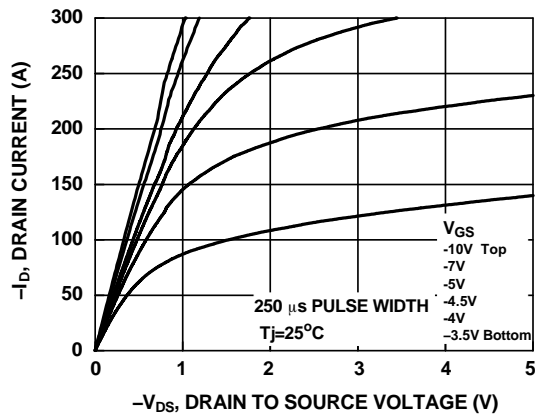


Figure 9. Saturation Characteristics

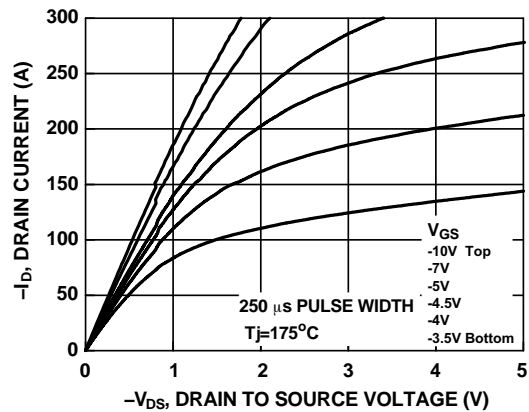


Figure 10. Saturation Characteristics

TYPICAL CHARACTERISTICS

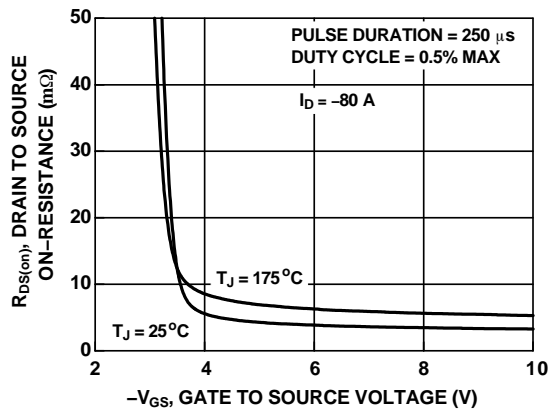
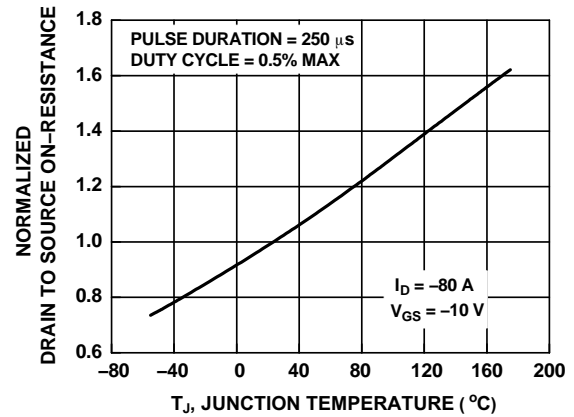
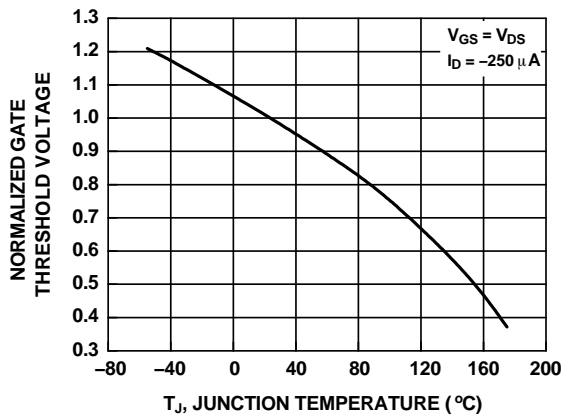
Figure 11. $R_{DS(on)}$ vs. Gate VoltageFigure 12. Normalized $R_{DS(on)}$ vs. Junction Temperature

Figure 13. Normalized Gate Threshold Voltage vs. Temperature

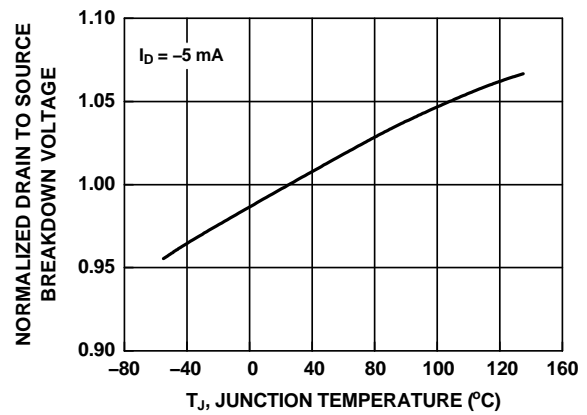


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

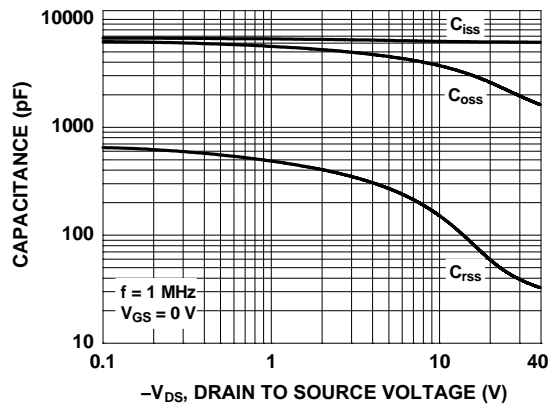


Figure 15. Capacitance vs. Drain to Source Voltage

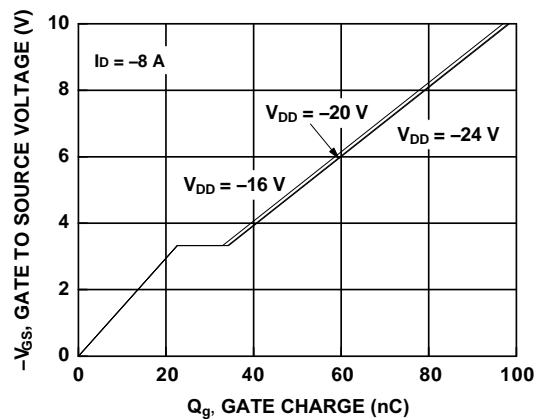


Figure 16. Gate Charge vs. Gate to Source Voltage

FDD9507L-F085

ORDERING INFORMATION

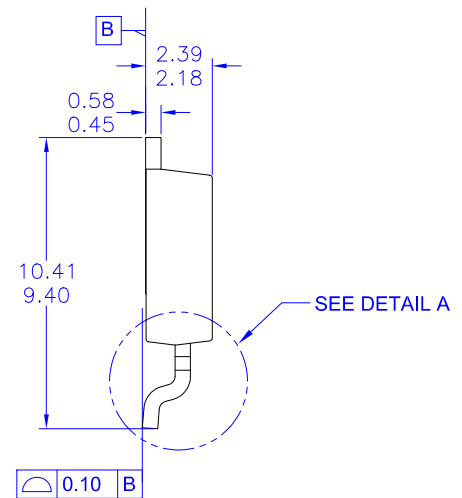
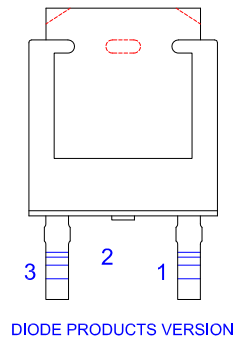
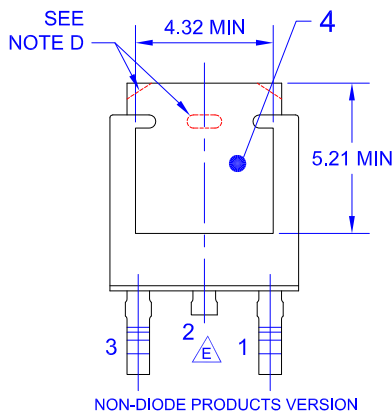
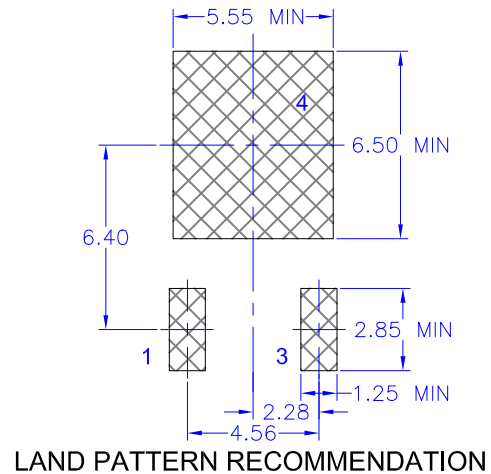
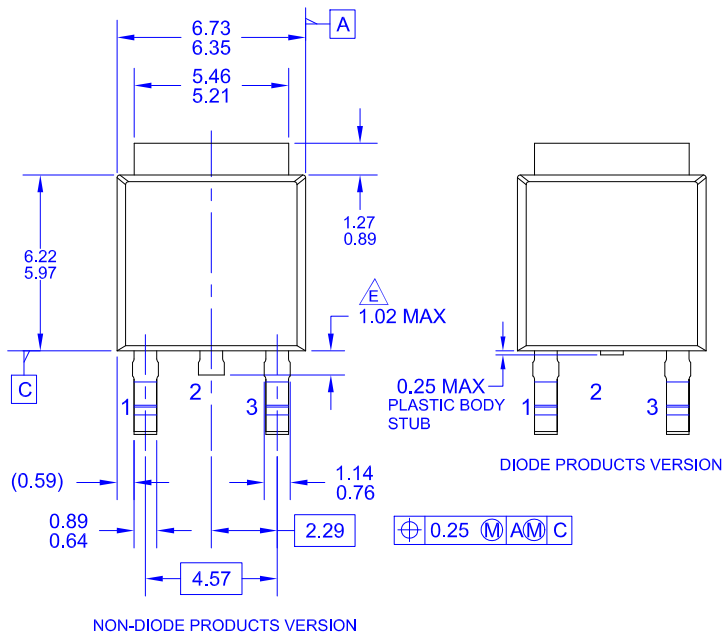
Device	Marking	Package	Reel Size	Tape Width	Quantity
FDD9507L-F085	FDD9507L	DPAK3 (TO-252) (Pb-Free / Halogen Free)	13"	16 mm	2500 Units

DPAK3 (TO-252 3 LD)

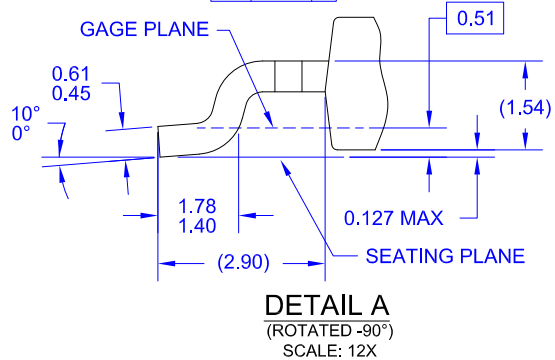
CASE 369AS

ISSUE O

DATE 30 SEP 2016



- NOTES: UNLESS OTHERWISE SPECIFIED
- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.
 - B) ALL DIMENSIONS ARE IN MILLIMETERS.
 - C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
 - D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
 - E) TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS
 - F) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
 - G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



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DESCRIPTION:	DPAK3 (TO-252 3 LD)	PAGE 1 OF 1

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